| 1 | Synthesis, Characterization, Volatility, and Thermal | | | | | | |
|----|--|--|--|--|--|--|--|
| 2 | Stability of Fluorinated Copper(II) Aminoalkoxide | | | | | | |
| 3 | Complexes as Potential Vapour Deposition Precursors | | | | | | |
| 4 | | | | | | | |
| 5 | Nicholas A. Hoffman [†] and David J. H. Emslie ^{†,*} | | | | | | |
| 6 | | | | | | | |
| 7 | | | | | | | |
| 8 | [†] Department of Chemistry and Chemical Biology, McMaster University, 1280 Main Street West, | | | | | | |
| 9 | Hamilton, Ontario, L8S 4M1, Canada. | | | | | | |
| 10 | | | | | | | |
| 11 | * E-mail: emslied@mcmaster.ca. Tel: 1-905-525-9140. Web: https://emsliegroup.mcmaster.ca | | | | | | |
| 12 | | | | | | | |
| 13 | | | | | | | |

14 ABSTRACT

| 15 | The sodium aminoalkoxides $Na[OCR(CF_3)CH_2NMeR']$ {R = H, R' = Me (1a); R = R' = Me (1b); R = |
|----|---|
| 16 | CF_3 , $R' = Me$ (1c); $R = Me$, $R' = Et$ (1d); $R = CF_3$, $R' = Et$ (1e)} were synthesized by reaction of the |
| 17 | corresponding fluorinated epoxide {OCH ₂ CR(CF ₃); $R = H(A)$, Me (B), CF ₃ (C)} with a secondary amine |
| 18 | (HNMe2 or HNMeEt), followed by deprotonation with sodium hydride. Compounds 1a-e were isolated |
| 19 | as white powders and characterized by combustion elemental analysis and NMR spectroscopy. Epoxides |
| 20 | A and C are commercially available, while epoxide B was prepared by <i>in-situ</i> deprotonation and |
| 21 | alkylation of A. Reactions of $1a-e$ with copper(II) chloride in THF afforded [Cu{OCR(CF_3)CH_2NMeR'}_2] |
| 22 | $\{R = H, R' = Me(2a); R = R' = Me(2b); R = CF_3, R' = Me(2c); R = Me, R' = Et(2d); R = CF_3, R' = CF_3, R' = Et(2d); R = CF_3, R' $ |
| 23 | (2e)}; compounds 2b and 2c have previously been reported but not structurally characterized, while 2a, |
| 24 | 2d, and 2e are new to this report. All copper(II) compounds were characterized by combustion elemental |
| 25 | analysis and single crystal X-ray crystallography. The physical properties of 2a-e were also evaluated |
| 26 | using thermogravimetric analysis (TGA), melting point, and sublimation (at 5 mTorr) data, with |
| 27 | comparison to previously reported non-fluorinated [Cu{OCHMeCH2NMe2}2] (III; [Cu(dmap)2]). |
| | |

Keywords: Copper complexes, ALD precursors, Fluorinated ligands, Aminoalkoxide ligands, Thermal
 stability & volatility

34 Introduction

Copper metal, which possesses a low resistivity and high resistance to electromigration, is traditionally 35 36 used as the interconnect material for integrated circuits, which includes the nano-scale wiring to transmit electrical signals between transistors.¹ However, as the physical dimensions of transistors decrease and 37 38 their complexity increases, there is growing demand for techniques to deposit ultra-thin copper films with a higher degree of uniformity, conformality, and purity.^{1b, 2} Atomic layer deposition (ALD) is a thin film 39 40 deposition method that can be used to deposit films which are more uniform and conformal than those 41 accessible via other methods, such as physical vapour (PVD) and chemical vapour deposition (CVD).³ 42 ALD relies upon self-limiting, surface-based chemical reactions between molecules, namely a precursor 43 and a co-reactant, which are delivered to the substrate surface in the vapour phase. Notably, an ideal ALD 44 precursor will display high thermal stability and volatility, as well as suitable reactivity towards a given co-reactant.3,4 45

A challenge in copper metal ALD^{3e,5} is the agglomeration of ultra-thin copper films at deposition 46 47 temperatures above 100 °C, ultimately leading to discontinuous films.⁶ Copper precursors which offer 48 increased volatility (while maintaining high reactivity and thermal stability) are therefore of particular 49 interest, since they could enable vapour-phase delivery into the ALD reactor at lower temperature. When 50 comparing the known compounds bis(2.4-pentanedionato)copper(II), [Cu(acac)₂], and bis(1.1.1.5.5.5-51 hexafluoro-2,4-pentanedionato)copper(II), [Cu(hfac)₂] (I and II in Figure 1), it is notable that fluorination of the ligand backbone leads to *substantially* improved volatility.⁷ Accordingly, when used as a precursor 52 for vapour deposition, [Cu(hfac)₂] is deliverable at a significantly lower temperature than non-fluorinated 53 [Cu(acac)₂].⁸ Similar ligand fluorination strategies have been employed to increase the volatility of 54 precursor molecules throughout the periodic table.⁹ and in an extension of this line of thinking, we sought 55 56 to investigate the influence of fluorination on the volatility of copper(II) aminoalkoxide complexes. Throughout academic and patent literature, a benchmark compound for low-temperature vapour 57 58 deposition of copper metal, especially in the context of ALD, is the copper(II) aminoalkoxide III (bis(dimethylamino-2-propoxy)copper(II), [Cu(dmap)₂]) (Figure 1).^{10,11,12} This compound displays high 59

volatility and thermal stability, making it an attractive precursor for various ALD processes.¹³ A range of 60 non-fluorinated analogues have also been described in the journal or patent literature.^{10, 11b, 11c, 12b} Herein, 61 62 we present the synthesis and characterization of the sodium salts of a series of fluorinated aminoalkoxide 63 ligands, and assessment of the influence of ligand substitution on the physical properties (especially 64 volatility and melting point) of the corresponding homoleptic copper(II) complexes, 65 $[Cu{OCR(CF_3)CH_2NMe_2}_2]$ {R = H, Me or CF_3) and $[Cu{OCR(CF_3)CH_2NMeEt}_2]$ (R = Me or CF_3). 66 The compounds featuring one methyl and one ethyl group on the amine donor were synthesized to explore the potential for increased ligand asymmetry to improve volatility,¹⁴ and for longer chain alkyl 67 68 substituents to afford complexes with lower melting points (ethyl substituents were used in order to 69 minimize molecular weight, in an effort to maximize volatility, and to maintain a low degree of steric 70 hindrance at the amine donor). Two of the five tertiary amine-containing copper complexes in this work, $[Cu{OCR(CF_3)CH_2NMe_2}_2]$ (R = Me and CF₃),^{12e} have previously been reported, and the related 71 72 fluorinated derivatives $[Cu{OC(CF_3)_2CH_2NR_2}_2]$ (R = allyl, ^{12c, 12d} CH₂CH₂OMe^{12b-d}) and $[Cu{OCH(CF_3)CH_2NR_2}_2]$ (R = "Pr, CH₂CH₂OMe)^{12c, 12d} have been described in the journal or patent 73 literature.¹² 74

75



77 Figure 1. Select copper(II) precursors used for vapour deposition of copper metal.

78

76

79 **Results and Discussion**

80 The sodium aminoalkoxides, Na[OCR(CF₃)CH₂NMeR'] {R = H, R' = Me (1a); R = R' = Me (1b); R = M

81 CF_3 , R' = Me (1c); R = Me, R' = Et (1d); $R = CF_3$, R' = Et (1e)}, were synthesized via a ring-opening

reaction of the corresponding fluorinated epoxides {OCH₂CR(CF₃); R = H (A), Me (B), CF₃ (C)} with a
secondary amine (HNMe₂ or HNMeEt), followed by deprotonation with sodium hydride (Scheme 1).
Compounds 1a-e were isolated as white powders and characterized by combustion elemental analysis and
NMR spectroscopy.

86



88 Scheme 1. Synthesis of sodium aminoalkoxide ligands 1a-e via ring-opening of A-C.

89

87

The commercial availability of **A** and **C** facilitated the synthesis of **1a**, **1c** and **1e**, while epoxide **B** (required for the synthesis of **1b** and **1d**) was prepared via *in-situ* deprotonation and alkylation of **A**. This deprotonation/alkylation method¹⁵ (**Scheme 2**) was chosen as an alternative to previous reports for the synthesis of **1b**, which utilized highly toxic and explosive diazomethane to generate **B**.^{12e}

94





97

95

Reaction of sodium aminoalkoxides 1a-e with copper(II) chloride in THF afforded the corresponding
paramagnetic copper(II) complexes [Cu{OCR(CF₃)CH₂NMeR'}₂] {R = H, R' = Me (2a); R = R' = Me
(2b); R = CF₃, R' = Me (2c); R = Me, R' = Et (2d); R = CF₃, R' = Et (2e)} in fair to good yields (Scheme
3). Complexes 2b and 2c were previously reported in the literature as potential CVD precursors,^{12e} while

102 2a, 2d, and 2e are new to this report. The complexes are volatile, and can be purified by sublimation *in* 103 vacuo (5 mTorr). All new complexes were characterized by combustion elemental analysis, melting point, and thermogravimetric analysis (vide infra). As 2a-e are paramagnetic, their ¹H and ¹⁹F NMR spectra 104 105 (Figures S23 and S24) feature very broad peaks which, although they do not provide detailed structural 106 information, can serve as a fingerprint for identification of these compounds. Compounds 2a-e all contain 107 tertiary alkyl amine groups, which avoids the potential for thermal decomposition involving 108 dehydrogenation to afford an imine (which has been considered as a possible decomposition pathway for related copper(II) aminoalkoxide complexes containing secondary or primary amine groups),^{12b} 109 110 potentially serving to increase the thermal stability of these complexes.

111





114

115 Purple crystals of complexes 2a-e were grown from concentrated toluene solutions and were characterized 116 by single crystal X-ray diffraction (while 2b and 2c are known compounds, their crystal structures have 117 not been previously reported). All compounds are square planar monomers, with a *trans* arrangement of 118 the oxygen donors, and no close intermolecular contacts. In all instances except for 2d, the copper centre 119 is located at a special position (an inversion centre). The crystal structures of **2a-b** and **2d-e**, which contain 120 at least one chiral centre in each ligand, exhibit some degree of disorder. However, it is notable that in 121 both disorder components of 2a and 2b, the CF₃ groups are located on either side of the square plane (i.e. 122 the molecules crystallize as *meso* (*RS*) diastereomers), and in both disorder components of **2e** the *N*-ethyl

groups are located on opposite sides of the square plane (i.e. 2e also crystallizes as the meso (RS) 123 124 diastereomer). By contrast, in both disorder components of 2d (which has two chiral centres per ligand), 125 (i) the CF₃ groups are located on opposite sides of the square plane and (ii) the ethyl groups are located 126 on the same side of the square plane as each other (i.e. the alpha carbon atoms in both ligands have 127 opposite chirality (RS), whereas the nitrogen atoms have the same chirality (RR or SS)); the major disorder 128 component in the X-ray crystal structure of 2d is shown in Figure 2. The Cu-O and Cu-N distances in 2a-e (Table 1) range from 1.871(1)-1.887(2) Å and 2.031(1)-2.050(4) Å, respectively, which are 129 130 comparable to those in other square planar copper(II) aminoalkoxide complexes (1.864(2)-1.897(2) Å and 2.017(2)-2.068(2) Å, respectively).^{12e,16} The O-Cu-O and N-Cu-N bond angles in **2a-c** and **2e** are 180° 131 132 due to the inversion centre at copper, whereas the square planar geometry in 2d is slightly distorted, with 133 O-Cu-O and N-Cu-N angles of 178.6(1)° and 178.0(1)° for the major disorder component (90%).

134



136 Figure 2. X-ray crystal structure of $[Cu{\kappa^2-OCMe(CF_3)CH_2NMeEt}_2]$ (2d). Hydrogen atoms are 137 omitted, and only the major disorder component (90%) is included for clarity. Thermal ellipsoids are 138 drawn at 50% probability.

139

135

Table 1. Cu-O and Cu-N distances in the X-ray crystal structures of 2a-e. [Disorder of the CuO₂N₂ core
is observed in 2b, 2d and 2e; * major disorder component (78% in 2b; 90% in 2d; 55% in 2e); ** minor
disorder component].

| Compound | Cu-O Distance (Å) | Cu-N Distance (Å) |
|----------|---|---|
| 2a | 1.871(1) | 2.031(1) |
| 2b | 1.876(2) | 2.049(2)* 2.050(4)** |
| 2c | 1.881(1) | 2.038(1) |
| 2d | 1.875(2)-1.887(2)* 1.880(2)-1.881(2)** | 2.036(2)-2.049(2)* 2.039(5)-2.041(5)** |
| 2e | 1.883(3)* 1.881(3)** | 2.040(3)* 2.047(3)** |

144

145 Sublimation temperatures for compounds 2a-e are listed in Table 2, and provide an indication of precursor volatility, although it is important to note that these data were obtained at a pressure of 5 mTorr, which is 146 147 significantly lower than that in a typical ALD experiment (commonly 0.1-1.0 Torr). To evaluate the 148 volatility (and thermal stability) of 2a-e in more detail, thermogravimetric analysis (TGA) of 2a-e was 149 conducted in an argon-filled glovebox at atmospheric pressure (Figure 3). The non-fluorinated copper(II) 150 aminoalkoxide compound III (Figure 1) was also synthesized and subjected to TGA under identical 151 experimental conditions; compound III has been widely employed as a highly volatile vapour deposition 152 precursor (vide supra), and thus comparison of the TGA data for 2a-e with III allows evaluation of the 153 influence of ligand fluorination on precursor volatility (compound 2a is the direct analogue of III, where 154 one methyl group in III has been replaced by a CF₃ group).

156 **Table 2.** Summary of the thermal properties of compounds **2a-e** and **III**.

| Compound | Sublimation Temperature (°C; 5 mTorr) | TGA T _{50%} (°C) | TGA Onset Temperature (°C) | TGA Residual Mass (%) | 1 Torr Temperature from TGA (°C) | Melting Point (°C) |
|------------|---|------------------------------|----------------------------------|-----------------------------|--|-----------------------|
| 2 a | 50-60 | 178 | 165 | 0.97 | 125 | 193-195 |
| 2b | 35-45 | 151 | 141 | 0.45 | 100 | 148-149 |

| 2c | 40-50 | 169 | 156 | 0.23 | 116 | 184-185 |
|-----|-------|-----|-----|------|-----|---------|
| 2d | 35-45 | 149 | 136 | 1.85 | 88 | 65-66 |
| 2e | 40-50 | 161 | 149 | 0.15 | 103 | 139-140 |
| III | 35-45 | 151 | 138 | 1.51 | 97 | 134-135 |

157



Figure 3. TGA mass loss curves for compounds 2a-e and III with a heating rate of 10 °C/min at atmospheric pressure in an Ar-filled glovebox. Sample masses used: 2a = 3.692 mg; 2b = 3.660 mg; 2c =5.163 mg; 2d = 1.925 mg; 2e = 4.149 mg; III = 3.377 mg.

162

163 All six compounds (2a-e and III) display a single mass loss step in the TGA, leaving minimal residual 164 mass, consistent with clean volatilization and thermal stability under the experimental conditions (on the 165 short timescale of the TGA experiment). The mass loss curves of the investigated compounds are 166 remarkably similar, with subtle differences in their volatility indicated by differing onset and 50% mass 167 loss temperatures ($T_{50\%}$) (**Table 2**). The most asymmetric complex, **2d**, is the most volatile, while **2b** and 168 III display nearly identical mass loss curves, and the direct trifluoromethyl analogue of III, compound 2a, is the least volatile. The latter result is contrary to our original hypothesis that ligand fluorination 169 170 would serve to improve the volatility of the corresponding copper aminoalkoxide. The temperatures at 171 which **2a-e** and **III** would achieve a vapour pressure of 1 Torr (**Table 2**) were also calculated from the TGA data using standard methodologies (described further in the supporting information)¹⁷ with ferrocene 172

173 as the calibrant. However, it is important to note that the calculation of a 1 Torr temperature is subject to 174 several assumptions, and serves more as an estimate of vapour pressure that allows for comparisons to be 175 made between similar precursors than as an absolute value.¹⁸

176 Melting points are also included in Table 2. When considering vapour-phase delivery, the 177 sublimation rate of a solid precursor will be dependent on the average particle size, which will change over time.¹⁹ In contrast, the evaporation rate of a liquid precursor should not be subject to such deviations, 178 179 thereby ensuring a more consistent rate of precursor delivery. Additionally, precursors which are liquid at the delivery temperature avoid potential issues with (i) concentration of impurities at the solid surface 180 as the precursor is consumed, hindering further volatilization,¹⁹ (ii) the transport of fine solid particles 181 182 into the reactor, and (iii) valve or delivery tube blockages caused by sublimation and deposition (the 183 reverse process of sublimation) of a solid precursor resulting from small temperature differences within 184 the precursor delivery vessel (anywhere between the inlet and outlet valves to/from the vessel). Thus, 185 from a practical perspective, precursors which are liquids at the delivery temperature are highly desirable. 186 Melting points were determined by heating a flame-sealed capillary containing **2a-e** or **III** (packed under 187 argon) in a melting point apparatus. Comparing compound 2a with III reveals that incorporation of a 188 trifluoromethyl group on the ligand backbone serves to increase the melting point of the copper complex 189 compared to the non-fluorinated derivative. By contrast, the melting point of 2d (65-66 °C) is significantly 190 lower than that of the other complexes (134-195 °C), and 2d is also the most volatile of the species in this 191 report, presumably due to the longer alkyl chain on nitrogen and the overall asymmetry of the ligands¹⁴ 192 in 2d, rather than as a direct result of ligand trifluoromethylation.

- 193
- 194

195 Summary and Conclusions

196 A family of fluorinated copper(II) aminoalkoxide complexes, $[Cu{OCR(CF_3)CH_2NMeR'}_2]$ {R = H, R' 197 = Me (2a); R = R' = Me (2b); $R = CF_3$, R' = Me (2c); R = Me, R' = Et (2d); $R = CF_3$, R' = Et (2e)}, were 198 synthesized and structurally characterized by single crystal X-ray diffraction and combustion elemental 199 analysis. Compounds **2b** and **2c** have previously been reported, but not structurally characterized, while 200 2a, 2d, and 2e are new to this work. The volatility, thermal stability and melting points of 2a-e were 201 evaluated by atmospheric pressure TGA, as well as sublimation (5 mTorr) and melting point data. For 202 comparison, analogous measurements were also performed on the commonly employed non-fluorinated 203 copper(II) aminoalkoxide precursor [Cu{OCHMeCH₂NMe₂}] (III; [Cu(dmap)₂]). All six compounds 204 (2a-e and III) were found to undergo a single mass loss step in the TGA, leaving minimal residual mass, 205 consistent with clean volatilization. Compound 2a, which is the direct fluorinated analogue of III (with 206 one CH₃ group replaced by a CF₃ group) is less volatile than III, with a significantly higher melting point 207 (193-195 °C vs 134-135 °C). By contrast, 2d is slightly more volatile than the other complexes, and has 208 a substantially lower melting point (65-66 °C vs 134-195 °C), likely due to the longer alkyl chain on 209 nitrogen and the overall asymmetry of the ligands, rather than as a direct result of ligand 210 trifluoromethylation. Overall, complexes 2a-e display sufficient volatility and thermal stability for 211 implementation in novel vapour deposition processes, and compound 2d offers the added benefit of a low 212 melting point; ALD precursors which are liquid at the delivery temperature are desirable to avoid changes 213 in the rate of precursor delivery resulting from changes in surface area, hindered volatilization due to 214 concentration of impurities at a solid surface, transport of fine particles into the reactor, and valve or 215 delivery tube blockages caused by sublimation and deposition (the reverse process of sublimation).

216

217 Experimental Section

General Details: An argon-filled MBraun UNIIab or Innovative Technology PureLab HE glove box equipped with a -35 °C freezer was employed for the manipulation and storage of all air-sensitive compounds, and reactions were performed on a double manifold vacuum line using standard techniques.²⁰

The vacuum was measured periodically using a Kurt J. Lesker 275i convection-enhanced Pirani gauge. Residual oxygen and moisture were removed from the argon stream by passage through an Oxisorb-W scrubber from Matheson Gas Products. Centrifugation was carried out using a Benchmark Hermle Z206A centrifuge housed within a glove box.

225 Hexanes, toluene, diethyl ether, and tetrahydrofuran were purchased from Sigma-Aldrich, and 226 deuterated solvents were purchased from Cambridge Isotope Laboratories. Solvents were initially dried 227 and distilled at atmospheric pressure from sodium/benzophenone (hexanes, diethyl ether, tetrahydrofuran, C₆D₆, d₈-THF) or sodium (toluene). All solvents were stored over sodium/benzophenone and introduced 228 229 to reactions or solvent storage flasks via vacuum transfer with condensation at -78 °C. Epoxides A and 230 **B** were purchased from SynQuest Laboratories and distilled to solvent storage flasks via vacuum transfer 231 with condensation at -78 °C prior to use. Complex III was synthesized according to literature procedures.^{10a} Dimethylamine (2.0 M in THF), N-ethylmethylamine, methyl iodide, sodium hydride, 232 233 "BuLi (1.6 M in hexanes), copper(II) chloride, and copper(II) methoxide were purchased from Sigma-234 Aldrich and used without further purification. 1-Dimethylamino-2-propanol was purchased from Sigma-235 Aldrich and dried over 4 Å molecular sieves and distilled to a solvent storage flask via vacuum transfer 236 with condensation at -78 °C.

NMR spectroscopy was performed on a Bruker AV-600 spectrometer. All ¹H NMR and ¹³C NMR spectra were referenced relative to SiMe₄ through the C_6D_6 or d₈-THF resonance or the protio impurity in the C_6D_6 or d₈-THF solvent: 7.16 and 3.58 ppm, respectively, for ¹H NMR and 128.06 and 67.21 ppm, respectively for ¹³C NMR. ¹⁹F NMR spectra were referenced by indirect referencing from a ¹H NMR spectrum.²¹ Peak assignments in the spectra of all new diamagnetic compounds were made with the aid of DEPT-q, COSY, HSQC and HMBC experiments.

Single-crystal X-ray crystallographic analyses were performed on crystals coated in Paratone oil and mounted on either a Bruker SMART APEX II diffractometer with a 3 kW sealed tube Mo generator and APEX II CCD detector or a STOE IPDS II diffractometer with an image plate detector in the McMaster Analytical X-ray Diffraction Facility. Raw data was processed using XPREP (as part of the APEX v2.2.0 software) and solved by an intrinsic method (SHELXT).²² In all cases, non-hydrogen atoms were refined anisotropically. Hydrogen atoms were either located from the distance map or generated in ideal positions and then updated with each cycle of refinement, which was performed with SHELXL in OLEX2-1.5.^{23,24}

251 Combustion elemental analyses were performed by Midwest Microlabs in Indianapolis, Indiana 252 or at the University of Calgary using a Perkin Elmer Model 2400 series II analyzer. Thermogravimetric 253 analysis was performed by Green Centre Canada in Kingston, Ontario using a TA Instruments Discovery 254 TGA located within an argon-filled glove box. Melting point determinations were performed by packing 255 the analyte into a flame-sealed pipette and sealing the open face of the pipette with Apiezon H-grease 256 inside an argon-filled glovebox. The pipette was then removed from the glovebox and quickly flame-257 sealed (below the grease but sufficiently distant from the analyte) to form a sealed capillary, which was 258 in turn used for analysis using a DigiMelt Melting Point Apparatus.

259

260 Synthetic Details:

261 Na[OCH(CF₃)CH₂NMe₂] (1a): Under an inert atmosphere, 0.806 g (7.19 mmol) of 262 2-(trifluoromethyl)oxirane (A) was charged to a 25 mL flask containing 5 mL of THF. The flask was 263 cooled to 0 °C and 7.91 mmol of dimethylamine (4.52 mL of a 1.75 M solution in THF) was added 264 dropwise with stirring. The reaction was stirred for 30 minutes at 0 °C, followed by stirring at room 265 temperature for 14 hours. The solvent and excess dimethylamine were removed at 0 °C in vacuo to yield 266 0.991 g (6.31 mmol) of a white crystalline powder. This powder was redissolved in 5 mL of THF, and the 267 resulting solution was added dropwise to a cooled (0 °C) 50 mL flask containing 0.167 g (6.94 mmol) of 268 sodium hydride suspended in 10 mL of THF. The reaction mixture was stirred for 4 hours at room 269 temperature and then evaporated to dryness in vacuo. Excess sodium hydride was removed by 270 centrifugation after addition of 5 mL of THF, and the resultant solution was evaporated to dryness in 271 *vacuo* to yield 1.064 g (5.94 mmol) of **1a** as a white powder (83% yield from **A**). This product is pure by 272 NMR spectroscopy, and was used in all subsequent reactions. However, elemental analysis was carried

out on crystals obtained by dissolving a sample of **1a** in a 3:1 mixture of hot toluene and THF, followed by cooling to -35 °C. ¹H NMR (d₈-THF, 600 MHz, 298 K): δ 4.19-4.24 (*m*, 1H, C*H*(CF₃)), 2.35 (*t*, 1H, ²*J*_{H,H}/³*J*_{H,H} = 10.8 Hz, C*H*₂), 2.23 (*s*, 6H, N(C*H*₃)₂), 2.03 (*d*, 1H, ²*J*_{H,H} = 10.8 Hz, C*H*₂). ¹³C {¹H} NMR (d₈-THF, 151 MHz, 298 K): δ 129.89 (*q*, ¹*J*_{C,F} = 287.4 Hz, CF₃), 72.40 (*q*, ²*J*_{C,F} = 25.4 Hz, C(CF₃)), 65.59 (*s*, CH₂), 45.83 (*s*, N(CH₃)₂). ¹⁹F NMR (d₈-THF, 565 MHz, 298 K): δ -82.29 (*d*, ³*J*_{F,H} = 4.0 Hz, C*F*₃). Anal. Calcd. for C₅H₉F₃NNaO (%): C, 33.52; H, 5.07; N 7.82. Found: C, 33.53; H, 5.04; N, 7.50.

279

280 Na[OCMe(CF₃)CH₂NMe₂] (1b): Under an inert atmosphere, 2.120 g (18.92 mmol) of 2-281 (trifluoromethyl)oxirane (A) was charged to a 250 mL flask containing 100 mL of THF and subsequently 282 cooled to -98 °C. A 1.10 M solution of "BuLi in hexanes (20 mL; 22.00 mmol) was then added dropwise 283 over the course of 15 minutes. This solution was stirred for an additional 10 minutes at -98 °C, whereupon 284 4.600 g (32.41 mmol) of methyl iodide was added. The reaction mixture was stirred for 1 hour at -98 °C 285 and then for an additional hour at -78 °C, whereupon the reaction temperature was raised to 0 °C. 70 286 mmol of dimethylamine (40.00 mL of 1.75 M solution in THF) was then added slowly, and the reaction 287 was stirred for 30 minutes at 0 °C, followed by stirring at room temperature for 14 hours. The reaction 288 mixture was then quenched with 90 mL of a saturated ammonium chloride solution, the organic layer 289 separated, and the aqueous layer extracted with 3 x 50 mL of diethyl ether. All organic layers were 290 combined, washed with 80 mL of a brine solution, and dried with magnesium sulfate. Solvent was 291 removed on a rotary evaporator, and the residual orange oil was distilled under vacuum to yield 3.191 g 292 of a clear, colourless oil. This oil was then dissolved in 5 mL of dry and degassed THF and added dropwise 293 to a 0 °C suspension of sodium hydride (0.491 g; 21.00 mmol) in 40 mL of THF. The mixture was stirred 294 for 4 hours at room temperature, filtered, and the filtrate was evaporated to dryness in vacuo to yield 2.467 295 g (13.00 mmol) of **1b** as a white solid (68% yield from **A**). This product is pure by NMR spectroscopy, 296 and was used in all subsequent reactions. However, elemental analysis was carried out on crystals obtained by dissolving a sample of **1b** in hot toluene, followed by cooling to $-35 \,^{\circ}$ C. ¹H NMR (d₈-THF, 600 MHz, 297

298 K): δ 2.43-2.46 (*m*, 1H, CH₂), 2.33 (*s*, 6H, N(CH₃)₂), 2.19-2.23 (*m*, 1H, CH₂), 1.16 (*s*, 3H, CH₃). 299 ¹³C{¹H} NMR (d₈-THF, 151 MHz, 298 K): δ 131.06 (*q*, ¹*J*_{C,F} = 297.0 Hz, CF₃), 75.48 (br *s*, *C*(CF₃)), 69.15, 69.08 (2 × *m*, CH₂)[†], 49.41, 49.33, 49.26 (3 × *m*, N(CH₃)₂)[†], 26.25, 26.16, 26.09 (3 × *m*, CH₃)[†]. ¹⁹F 301 NMR (d₈-THF, 565 MHz, 298 K): δ –83.85, –83.95, –84.00 (3 × *m*, CF₃)[†]. Anal. Calcd. for C₆H₁₁F₃NNaO 302 (%): C, 37.30; H, 5.75; N 7.25. Found: C, 37.76; H, 6.13; N, 7.18. [†] Multiple peaks are likely due to 303 diastereomers resulting from aggregation.

304

305 Na[OC(CF₃)₂CH₂NMe₂] (1c): Under an inert atmosphere, 1.878 g (10.43 mmol) of 2,2-306 bis(trifluoromethyl)oxirane (C) was charged to a 25 mL flask containing 5 mL of THF. The flask was 307 cooled to 0 °C and 11.47 mmol of dimethylamine (6.55 mL of a 1.75 M solution in THF) was added 308 dropwise with stirring. The reaction was stirred for 30 minutes at 0 °C, followed by stirring at room 309 temperature for 14 hours. The solvent and excess dimethylamine were removed at 0 °C in vacuo to yield 310 1.744 g (7.74 mmol) of a clear, light yellow oil. This oil was dissolved in 5 mL of THF and added dropwise 311 to a cooled (0 °C) 50 mL flask containing 0.204 g (8.52 mmol) of sodium hydride suspended in 10 mL of 312 THF. The reaction mixture was stirred for 4 hours at room temperature and then evaporated to dryness in 313 vacuo. Excess sodium hydride was removed by centrifugation after addition of 5 mL of THF, and the 314 resultant solution was evaporated to dryness *in vacuo* to yield 1.830 g (7.40 mmol) of 1c as a white powder 315 (71% yield from C). This product is pure by NMR spectroscopy, and was used in all subsequent reactions. 316 However, elemental analysis was carried out on crystals obtained by dissolving a sample of 1c in hot toluene, followed by cooling to -35 °C. ¹H NMR (d₈-THF, 600 MHz, 298 K): δ 2.52 (s, 2H, CH₂), 2.31 317 (s, 6H, N(CH₃)₂). ¹³C{¹H} NMR (d₈-THF, 151 MHz, 298 K): δ 127.62 (q, ¹J_{C,F} = 294.7 Hz, CF₃), 81.63 318 $(sept, {}^{2}J_{C,F} = 23.6 \text{ Hz}, C(CF_{3})_{2}), 62.70 (s, CH_{2}), 48.62 (s, N(CH_{3})_{2}). {}^{19}\text{F} \text{ NMR} (d_{8}\text{-THF}, 565 \text{ MHz}, 298)$ 319 320 K): δ -79.38 (s, CF₃). Anal. Calcd. for C₆H₈F₆NNaO (%): C, 29.16; H, 3.27; N 5.67. Found: C, 29.20; 321 H. 3.40: N. 5.63.

323 Na[OCMe(CF3)CH2NMeEt] (1d): Under an inert atmosphere, 0.918 g (8.20 mmol) of 2-324 (trifluoromethyl)oxirane (A) was charged to a 100 mL flask containing 40 mL of THF and subsequently 325 cooled to -98 °C. A 1.10 M solution of "BuLi in hexanes (8.20 mL; 9.02 mmol) was then added dropwise 326 over the course of 10 minutes. This solution was stirred for an additional 10 minutes at -98 °C, whereupon 327 2.287 g (16.11 mmol) of methyl iodide was added. The reaction mixture was stirred for 1 hour at -98 °C 328 and stirred for an additional hour at -78 °C, whereupon the reaction temperature was raised to 0 °C. 32.00 329 mmol of N-ethylmethylamine (18.30 mL of a 1.75 M solution in THF) was then added slowly, and the reaction was stirred for 30 minutes at 0 °C, followed by stirring at room temperature for 14 hours. The 330 331 reaction mixture was then quenched with 40 mL of a saturated ammonium chloride solution, the organic 332 layer separated, and the aqueous layer extracted with 3 x 20 mL of diethyl ether. All organic layers were 333 combined, washed with 40 mL of a brine solution, and dried with magnesium sulfate. Solvent was 334 removed on a rotary evaporator, and the residual orange oil distilled under vacuum to yield 1.248 g (6.74 335 mmol) of a clear, colourless oil. This oil was then dissolved in 5 mL of dry and degassed THF and added 336 dropwise to a 0 °C suspension of sodium hydride (0.178 g; 7.42mmol) in 15 mL of THF. The mixture 337 was stirred for 4 hours at room temperature, filtered, and evaporated to dryness in vacuo to yield 1.166 g 338 (5.63 mmol) of 1d as a white solid (69% yield from A). This product is pure by NMR spectroscopy, and 339 was used in all subsequent reactions. However, elemental analysis was carried out on crystals obtained 340 by cooling a concentrated toluene solution of 1d to -35 °C. ¹H NMR (d₈-THF, 600 MHz, 298 K): δ 2.51-341 2.55 (*m*, 2H, N(CH₂CH₃)), 2.36 (*s*, 2H, CH₂), 2.31 (*s*, 3H, N(CH₃), 1.16 (*s*, 3H, CH₃), 1.02 (*t*, 3H, ${}^{3}J_{H,H} =$ 7.1 Hz, N(CH₂CH₃)). ¹³C{¹H} NMR (d₈-THF, 151 MHz, 298 K): δ 131.28 (*q*, ¹*J*_{C,F} = 293.6 Hz, *C*F₃), 342 75.44 (q, ${}^{2}J_{C,F}$ = 22.1 Hz, $C(CF_{3})$), 67.59* (CH_{2}), 55.00 (s, N($CH_{2}CH_{3}$), 44.31 (s, N(CH_{3})), 25.99 (s, CH_{3}), 343 344 11.95 (s, N(CH₂CH₃)). ¹⁹F NMR (d₈-THF, 565 MHz, 298 K): δ -83.18, -83.21, -83.26, -83.34, -83.47 345 $(5 \times m, CF_3)^{\dagger}$. Anal. Calcd. for C₇H₁₃F₃NNaO (%): C, 40.57; H, 6.34; N 6.76. Found: C, 40.40; H, 6.53; 346 N, 6.70. * Peak obscured by d⁸-THF solvent signal, identified by ¹H-¹³C HSOC. [†] Multiple peaks are likely 347 due to diastereomers resulting from aggregation.

349 Na[OC(CF₃)₂CH₂NMeEt] (1e): Under an inert atmosphere, 0.500 g (2.78 mmol) of 2,2-350 bis(trifluoromethyl)oxirane (C) was charged to a 25 mL flask containing 5 mL of THF. The flask was 351 cooled to 0 °C and 3.06 mmol of N-ethylmethylamine (1.75 mL of a 1.75 M solution in THF) was added 352 dropwise with stirring. The reaction was stirred for 30 minutes at 0 °C, followed by stirring at room 353 temperature for 14 hours. The solvent and excess N-ethylmethylamine were removed at 0 °C in vacuo to 354 yield 0.622 g (2.77 mmol) of a clear, light-yellow oil. This oil was dissolved in 5 mL of THF and added 355 dropwise to a cooled (0 °C) 50 mL flask containing 0.072 g (3.00 mmol) of sodium hydride suspended in 356 10 mL of THF. The reaction mixture was stirred for 4 hours at room temperature and then evaporated to 357 dryness in vacuo. Excess sodium hydride was removed by centrifugation after addition of 5mL of THF, 358 and the resultant solution was evaporated to dryness in vacuo to yield 0.667 g (2.55 mmol) of 1e as a 359 white powder (92% yield from C). This product is pure by NMR spectroscopy, and was used in all 360 subsequent reactions. However, elemental analysis was carried out on crystals obtained by cooling a 361 concentrated toluene solution of 1e to -35 °C. ¹H NMR (d₈-THF, 600 MHz, 298 K): δ 2.57 (s, 2H, CH₂), 2.51 (q, 2H, ${}^{3}J_{H,H} = 7.2$ Hz, N(CH₂CH₃)), 2.32 (s, 3H, N(CH₃)), 1.01 (t, 3H, ${}^{3}J_{H,H} = 7.2$ Hz, N(CH₂CH₃)). 362 ¹³C{¹H} NMR (d₈-THF, 151 MHz, 298 K): δ 127.68 (q, ¹J_{C,F} = 295.3 Hz, CF₃), 81.61 (br s, C(CF₃)₂), 363 364 60.81 (s, CH₂), 54.49 (s, N(CH₂CH₃)), 44.35 (s, N(CH₃)), 12.13 (s, N(CH₂CH₃)). ¹⁹F NMR (d₈-THF, 565 365 MHz, 298 K): δ –79.26 (s, CF₃). Anal. Calcd. for C₇H₁₃F₃NNaO (%): C, 32.19; H, 3.87; N 5.36. Found: 366 C, 32.27; H, 4.07; N, 5.34.

367

368 [Cu{OCH(CF₃)CH₂NMe₂] (2a): In an argon-filled glovebox, a solution containing 0.484 g (2.70 369 mmol) of 1a in 5 mL of THF was added to a stirring suspension of CuCl₂ (0.182 g; 1.35 mmol) in 5 mL 370 of THF. The reaction mixture was stirred for 16 hours, filtered, and evaporated to dryness *in vacuo* to 371 yield a purple solid, which was purified by sublimation under vacuum (50-60 °C, 5 mTorr) to yield 0.262 372 g (0.70 mmol) of 2a as a purple, crystalline solid (52% yield). X-ray quality crystals of 2a were obtained

- 373 by cooling a concentrated toluene solution to -35 °C. ¹H NMR (C₆D₆, 600 MHz, 298 K): δ ~24 (br *s*), 374 ~14 (br *s*). ¹⁹F NMR (C₆D₆, 565 MHz, 298 K): δ ~(-58) (br *s*). Melting Point: 193-195 °C. Anal. Calcd. 375 for C₁₀H₁₈CuF₆O₂N₂ (%): C, 32.09; H, 4.65; N 7.82. Found: C, 31.95; H, 4.84; N, 7.46.
- 376

377 [Cu{OCMe(CF3)CH2NMe2]2] (2b): In an argon-filled glovebox, a solution containing 2.135 g (11.00 378 mmol) of **1b** in 10 mL of THF was added to a stirring suspension of CuCl₂ (0.740 g; 5.50 mmol) in 10 379 mL of THF. The reaction mixture was stirred for 16 hours, filtered, and evaporated to dryness in vacuo to 380 vield a purple solid, which was purified by sublimation under vacuum (35-45 °C, 5 mTorr) to vield 1.922 381 g (4.76 mmol) of **2b** as a purple crystalline solid (87% yield). X-ray quality crystals of **2b** were obtained by cooling a concentrated toluene solution to -35 °C. ¹H NMR (C₆D₆, 600 MHz, 298 K): $\delta \sim 15$ (br s). ¹⁹F 382 383 NMR C₆D₆, 565 MHz, 298 K): δ ~(-86) (br s). Melting Point: 148-149 °C. Anal. Calcd. for 384 C₁₂H₂₂CuF₆O₂N₂ (%): C, 35.44; H, 5.84; N 6.77. Found: C, 35.69; H, 5.49; N, 6.94.

385

386 [Cu{OC(CF3)2CH2NMe2}2] (2c): In an argon-filled glovebox, a solution containing 0.727 g (2.94 mmol) 387 of 1c in 5 mL of THF was added to a stirring suspension of CuCl₂ (0.198 g; 1.47 mmol) in 5 mL of THF. 388 The reaction mixture was stirred for 16 hours, filtered, and evaporated to dryness in vacuo to yield a 389 purple solid, which was purified by sublimation under vacuum (40-50 °C, 5 mTorr) to yield 0.558 g (1.09 390 mmol) of **2c** as a purple crystalline solid (74% yield). X-ray quality crystals of **2c** were obtained by cooling 391 a concentrated toluene solution to -35 °C. ¹H NMR (C₆D₆, 600 MHz, 298 K): No observable signals in the range of ± -100 ppm. ¹⁹F NMR (C₆D₆, 565 MHz, 298 K): $\delta \sim (-68)$ (br s). Melting Point: 184-185 392 393 °C. Anal. Calcd. for C₁₂H₁₆CuF₁₂O₂N₂ (%): C, 27.99; H, 3.42; N 5.31. Found: C, 28.16; H, 3.15; N, 5.47. 394

395 [Cu{κ²-OCMe(CF₃)CH₂NMeEt}₂] (2d): In an argon-filled glovebox, a solution containing 0.829 g (4.00
396 mmol) of 1d in 5 mL of THF was added to a stirring suspension of CuCl₂ (0.269 g; 2.00 mmol) in 5 mL
397 of THF. The reaction mixture was stirred for 16 hours, filtered, and evaporated to dryness *in vacuo* to

398 yield a purple solid, which was purified by sublimation under vacuum (35-45 °C, 5 mTorr) to yield 0.694 399 g (1.61 mmol) of **2d** as a purple crystalline solid (81% yield). X-ray quality crystals of **2d** were obtained 400 by cooling a concentrated hexanes solution to -35 °C. ¹H NMR (C₆D₆, 600 MHz, 298 K): $\delta \sim 18$ (br *s*), 401 ~11 (br *s*), ~10 (br *s*), ~8 (br *s*), ~7 (br *s*), ~3 (br *s*), ~2 (br *s*). ¹⁹F NMR (C₆D₆, 565 MHz, 298 K): $\delta \sim (-70)$ 402 (br *s*), ~(-87) (br *s*). Melting Point: 65-66 °C. Anal. Calcd. for C₁₄H₂₆CuF₆O₂N₂ (%): C, 39.06; H, 6.25; 403 N, 6.60. Found: C, 38.92; H, 6.08; N, 6.49.

404

405 [Cu{OC(CF₃)₂CH₂NMeEt₂] (2e): In an argon-filled glovebox, a solution containing 0.522 g (2.00 406 mmol) of 1e in 5 mL of THF was added to a stirring suspension of CuCl₂ (0.134 g; 1.00 mmol) in 5 mL 407 of THF. The reaction mixture was stirred for 16 hours, filtered, and evaporated to dryness in vacuo to 408 yield a purple solid, which was purified by sublimation under vacuum (40-50 °C, 5 mTorr) to yield 0.419 409 g (0.78 mmol) of 2e as a purple crystalline solid (78% yield). X-ray quality crystals of 2e were obtained by cooling a concentrated toluene solution to -35 °C. ¹H NMR (C₆D₆, 600 MHz, 298 K): $\delta \sim 20$ (br s), 410 ~15 (br s), ~2 (br s). ¹⁹F NMR (C₆D₆, 565 MHz, 298 K): δ ~(-59) (br s), ~(-65) (br s), ~(-70) (br s). 411 412 Melting Point: 139-140 °C. Anal. Calcd. for C₁₄H₂₀CuF₁₂O₂N₂ (%): C, 31.24; H, 3.60; N, 5.17. Found: 413 C, 31.14; H, 3.74; N, 5.19.

414

415 ASSOCIATED CONTENT

416 Data Availability. ¹H, ¹³C{¹H}, ¹⁹F and selected 2D NMR spectra, and general X-ray crystal structure 417 data and refinement details are provided in the Supporting Information. CCDC 2324430-2324434 contain 418 the supplementary crystallographic data for compounds 2a-2e, respectively. These data can be obtained, 419 free of charge, via www.ccdc.cam.ac.uk/data_request/cif (or from the Cambridge Crystallographic Data 420 Centre, 12 Union Road, Cambridge CB2 1EZ, UK; fax: +44 1223 336033; or email: 421 deposit@ccdc.cam.ac.uk).

422

424 **COMPETING INTERESTS**

425 There are no competing interests to declare.

426

427 ACKNOWLEDGMENT

D.J.H.E. thanks NSERC of Canada for a Discovery grant (RGPIN-2020-06794), and the Ontario government for an Ontario Research Fund Research Excellence grant (ORF-RE-09-051). We are also grateful to Dr. Robert G. Syvret and EFC Gases and Advanced Materials for their contributions to the ORF-RE grant. N.A.H. thanks NSERC of Canada for CGS-M and PGS-D scholarships, and the Ontario government for an Ontario Graduate Fellowship (OGF). We are grateful to Dr. Yurij Mozharivskyj for access to his X-ray diffractometer, and Dr. Jeffrey S. Price for assistance with X-ray crystallography.

434

435 **REFERENCES**

- 436 (1) (a) Li, Z.; Tian, Y.; Teng, C.; Cao, H. Recent Advances in Barrier Layer of Cu Interconnects. *Materials*
- 437 **2020**, *13* (21), 5049. (b) Kim, H.-W. Recent Trends in Copper Metallization. *Electronics* **2022**, *11* (18),
- 438 2914. (c) Moon, J. H.; Jeong, E.; Kim, S.; Kim, T.; Oh, E.; Lee, K.; Han, H.; Kim, Y. K. Materials Quest
- 439 for Advanced Interconnect Metallization in Integrated Circuits. *Adv. Sci.* **2023**, *10* (23), 2207321.
- 440 (2) (a) Leskelä, M.; Ritala, M. Atomic Layer Deposition Chemistry: Recent Developments and Future
- 441 Challenges. Angew. Chem. Int. Ed. 2003, 42 (45), 5548-5554. (b) Kim, H. The application of atomic layer
- 442 deposition for metallization of 65 nm and beyond. *Surf. Coat. Technol.* **2006**, *200* (10), 3104-3111.

443 (3) (a) Vidjayacoumar, B.; Emslie, D. J. H.; Clendenning, S. B.; Blackwell, J. M.; Britten, J. F.; Rheingold,

444 A. Investigation of AlMe₃, BEt₃, and ZnEt₂ as Co-Reagents for Low-Temperature Copper Metal

- 445 ALD/Pulsed-CVD. Chem. Mater. 2010, 22 (17), 4844-4853. (b) Knisley, T. J.; Kalutarage, L. C.; Winter,
- 446 C. H. Precursors and chemistry for the atomic layer deposition of metallic first row transition metal films.
- 447 Coord. Chem. Rev. 2013, 257 (23), 3222-3231. (c) Miikkulainen, V.; Leskelä, M.; Ritala, M.; Puurunen,
- 448 R. L. Crystallinity of inorganic films grown by atomic layer deposition: Overview and general trends. J.
- 449 Appl. Phys. 2013, 113 (2), 021301. (d) Hagen, D. J.; Pemble, M. E.; Karppinen, M. Atomic layer

- 450 deposition of metals: Precursors and film growth. Appl. Phys. Rev. 2019, 6 (4), 041309. (e) Gordon, P.
- 451 G.; Kurek, A.; Barry, S. T. Trends in Copper Precursor Development for CVD and ALD Applications.
- 452 *ECS J. Solid State Sci. Technol.* **2015**, *4* (1), N3188.
- (4) Devi, A. 'Old Chemistries' for new applications: Perspectives for development of precursors for
 MOCVD and ALD applications. *Coord. Chem. Rev.* 2013, 257 (23), 3332-3384.
- 455 (5) Tripathi, T. S.; Wilken, M.; Hoppe, C.; de los Arcos, T.; Grundmeier, G.; Devi, A.; Karppinen, M.
- 456 Atomic Layer Deposition of Copper Metal Films from Cu(acac)₂ and Hydroquinone Reductant. *Adv. Eng.*
- 457 *Mater.* **2021**, *23* (10), 2100446.
- 458 (6) (a) Dai, M.; Kwon, J.; Halls, M. D.; Gordon, R. G.; Chabal, Y. J. Surface and Interface Processes
- 459 during Atomic Layer Deposition of Copper on Silicon Oxide. *Langmuir* **2010**, *26* (6), 3911-3917. (b)
- 460 Park, K.-M.; Kim, J.-K.; Han, B.; Lee, W.-J.; Kim, J.; Shin, H.-K. Influence of the deposition temperature
- 461 on the properties of copper thin films prepared by alternating injection of Cu(ethylketoiminate)₂ and H₂
- 462 on a ruthenium substrate. *Microelectron. Eng.* 2012, 89, 27-30. (c) Hagen, D. J.; Connolly, J.; Povey, I.
- 463 M.; Rushworth, S.; Pemble, M. E. Island Coalescence during Film Growth: An Underestimated Limitation
- 464 of Cu ALD. Adv. Mater. Interfaces 2017, 4 (18), 1700274. (d) Yao, Y.; Chen, B.; Zaera, F. On the
- 465 Mechanism of the Atomic Layer Deposition of Cu Films on Silicon Oxide Surfaces: Activation Using
- 466 Atomic Hydrogen and Three-Dimensional Growth. *Chem. Mater.* **2023**, *35* (5), 2155-2164.
- 467 (7) Fahlman, B. D.; Barron, A. R. Substituent effects on the volatility of metal β -diketonates. *Adv. Mater.*
- 468 *Opt. Electron.* **2000**, *10* (3-5), 223-232.
- 469 (8) Bernal Ramos, K.; Saly, M. J.; Chabal, Y. J. Precursor design and reaction mechanisms for the atomic
- 470 layer deposition of metal films. *Coord. Chem. Rev.* **2013**, 257 (23), 3271-3281.
- 471 (9) Donald, C. B.; Halina, C.; Michael, B. H.; Majid, M.; Ruowen, W. Fluorinated tertiary alkoxides of
- 472 some lanthanides: tris-trifluorotertiarybutoxides of lanthanum, praseodymium and europium. *Polyhedron*
- **1993**, *12* (24), 2955-2960.
- 474 (10) (a) Becker, R.; Weiß, J.; Winter, M.; Merz, K.; Fischer, R. A. New heterometallic copper zinc
- 475 alkoxides: synthesis, structure properties and pyrolysis to Cu/ZnO composites. J. Organomet. Chem.

- 476 2001, *630* (2), 253-262. (b) Baum, T. H.; Bhandari, G.; Xu, C. Chemical vapor deposition precursors for
 477 deposition of copper. US6822107B1, 2004.
- 478 (11) For literature discussing the synthesis of non-fluorinated derivatives of [Cu(dmap)₂] which contain

479 a tertiary amine, see: (a) Park, J. W.; Jang, H. S.; Kim, M.; Sung, K.; Lee, S. S.; Chung, T.-M.; Koo, S.;

- 480 Kim, C. G.; Kim, Y. Synthesis of Cu(II) aminoalkoxide complexes and their unusual thermolysis to Cu(0).
- 481 Inorg. Chem. Commun. 2004, 7 (4), 463-466. (b) Kim, Y.; Kim, C. G.; Chung, T.-M.; Lee, S. S.; An, K.-
- 482 S.; Yang, T. S.; Jang, H. S. Volatile copper aminoalkoxide complex and deposition of copper thin film
- 483 using same. US6982341B1, 2006. (c) Tomaharu, Y.; Masaki, E.; Atsushi, S.; Akihiro, N.; Makoto, O.
- 484 Copper Compound, Starting Material for Forming Thin Film, and Method for Manufacturing Thin Film.
- 485 US2017044188A1, 2017.
- 486 (12) For literature discussing the synthesis of derivatives of [Cu(dmap)₂] containing a primary or
 487 secondary amine, see: (a) Chang, I.-S.; Willis, C. J. Fluorinated alkoxides. Part XI. Studies on highly
- 488 fluorinated amino-alcohols and their metal derivatives. *Can. J. Chem.* **1977**, *55* (13), 2465-2472. (b) Hsu,
- 489 P. F.; Chi, Y.; Lin, T. W.; Liu, C. S.; Carty, A. J.; Peng, S. M. Self-Reducible Cu^{II} Source Reagents for
- 490 the CVD of Copper. Chem. Vap. Depos. 2001, 7 (1), 28-31. (c) Peng-Fu, H.; Lin, T.-W.; Liun, C.-S.;
- 491 Carty, A. J. Self-reducible and self-decomposing copper metalorganic complexes for deposition of electric
- 492 conducting copper metal films. WO2001094291A1, 2001. (d) Chi, Y.; Hsu, P.-F.; Lin, T.-W.; Liu, C.-S.;
- 493 Carty, A. J. Self-reducible copper(II) source reagents for chemical vapor deposition of copper metal.
- 494 US6369256B1, 2002. (e) Chi, Y.; Hsu, P.-F.; Liu, C.-S.; Ching, W.-L.; Chou, T.-Y.; Carty, A. J.; Peng,
- 495 S.-M.; Lee, G.-H.; Chuang, S.-H. Fluorinated aminoalkoxide Cu^{II} complexes: new CVD precursors for
- 496 deposition of copper metal. J. Mater. Chem. 2002, 12 (12), 3541-3550.
- 497 (13) For literature discussing new copper ALD processes with [Cu(dmap)₂], see: (a) Lee, B. H.; Hwang,
- 498 J. K.; Nam, J. W.; Lee, S. U.; Kim, J. T.; Koo, S.-M.; Baunemann, A.; Fischer, R. A.; Sung, M. M. Low-
- 499 Temperature Atomic Layer Deposition of Copper Metal Thin Films: Self-Limiting Surface Reaction of
- 500 Copper Dimethylamino-2-propoxide with Diethylzinc. Angew. Chem. Int. Ed. 2009, 48 (25), 4536-4539.
- 501 (b) Knisley, T. J.; Ariyasena, T. C.; Sajavaara, T.; Saly, M. J.; Winter, C. H. Low Temperature Growth

502 of High Purity, Low Resistivity Copper Films by Atomic Layer Deposition. *Chem. Mater.* 2011, 23 (20),

503 4417-4419. (c) Kalutarage, L. C.; Clendenning, S. B.; Winter, C. H. Low-Temperature Atomic Layer

504 Deposition of Copper Films Using Borane Dimethylamine as the Reducing Co-reagent. *Chem. Mater.*

505 **2014**, 26 (12), 3731-3738. (d) Väyrynen, K.; Mizohata, K.; Räisänen, J.; Peeters, D.; Devi, A.; Ritala, M.;

- 506 Leskelä, M. Low-Temperature Atomic Layer Deposition of Low-Resistivity Copper Thin Films Using
- 507 Cu(dmap)₂ and Tertiary Butyl Hydrazine. *Chem. Mater.* **2017**, *29* (15), 6502-6510.
- 508 (14) For select examples of the influence of ligand asymmetry on precursor volatility and/or melting point, 509 see: (a) Park, K.-H.; Marshall, W. J. Remarkably Volatile Copper(II) Complexes of N,N'-510 Unsymmetrically Substituted 1,3-Diketimines as Precursors for Cu Metal Deposition via CVD or ALD. 511 J. Am. Chem. Soc. 2005, 127 (26), 9330-9331. (b) Baunemann, A.; Lemberger, M.; Bauer, A. J.; Parala, 512 H.; Fischer, R. A. MOCVD of TaN Using the All-Nitrogen-Coordinated Precursors [Ta(NEtMe)₃(N-513 tBu)], $[Ta(NEtMe)(N-tBu){C(N-iPr)_2(NEtMe)}_2]$, and $[Ta(NMeEt)_2(N-tBu){Me_2N-N(SiMe_3)}]$. Chem. 514 Vap. Depos. 2007, 13 (2-3), 77-83. (c) Eleter, M.; Daniele, S.; Brize, V.; Dubourdieu, C.; Lachaud, C.; 515 Blasco, N.; Pinchart, A. Remarkable Influence of molecular structure of N.N'-unsymmetrically substituted 516 1,3-amidinate and -guanidinate on the Volatility and the Thermal Stability of Precursors for HfO₂ Films 517 via Liquid Injection-MOCVD. ECS Trans. 2009, 25 (8), 151. (d) Chen, T.; Xu, C.; Baum, T. H.; Stauf, 518 G. T.; Roeder, J. F.; DiPasquale, A. G.; Rheingold, A. L. New Tantalum Amido Complexes with Chelate 519 Ligands as Metalorganic (MO) Precursors for Chemical Vapor Deposition (CVD) of Tantalum Nitride 520 Thin Films. Chem. Mater. 2010, 22 (1), 27-35. (e) Krasnopolski, M.; Hrib, C. G.; Seidel, R. W.; Winter,
- 521 M.; Becker, H.-W.; Rogalla, D.; Fischer, R. A.; Edelmann, F. T.; Devi, A. Homoleptic Gadolinium
- 522 Amidinates as Precursors for MOCVD of Oriented Gadolinium Nitride (GdN) Thin Films. *Inorg. Chem.*

523 **2013**, 52 (1), 286-296. (f) Lubitz, K.; Sharma, V.; Shukla, S.; Berthel, J. H. J.; Schneider, H.; Hoßbach,

- 524 C.; Radius, U. Asymmetrically Substituted Tetrahedral Cobalt NHC Complexes and Their Use as ALD
- 525 as well as Low-Temperature CVD Precursors. Organometallics 2018, 37 (7), 1181-1191. (g) Soussi, K.;
- 526 Mishra, S.; Jeanneau, E.; Mantoux, A.; Daniele, S. Synthesis, characterization and thermal transport
- 527 properties of heteroleptic N-alkyl triazenide complexes of titanium(IV) and niobium(V). Polyhedron

- 528 **2018**, *152*, 84-89. (h) Gakiya-Teruya, M.; Jiang, X.; Le, D.; Üngör, Ö.; Durrani, A. J.; Koptur-Palenchar,
- 529 J. J.; Jiang, J.; Jiang, T.; Meisel, M. W.; Cheng, H.-P.; et al. Asymmetric Design of Spin-Crossover
- 530 Complexes to Increase the Volatility for Surface Deposition. J. Am. Chem. Soc. 2021, 143 (36), 14563-
- 531 14572. (i) Samii, R.; Buttera, S. C.; Kessler, V.; O'Brien, N. J. Synthesis, Structure and Thermal Properties
- of Volatile Indium and Gallium Triazenides. *Eur. J. Inorg. Chem.* **2022**, 2022 (24), e202200161.
- 533 (15) Yamauchi, Y.; Katagiri, T.; Uneyama, K. The First Generation and Stereospecific Alkylation of α-
- 534 Trifluoromethyl Oxiranyl Anion. Org. Lett. 2002, 4 (2), 173-176.
- 535 (16) Goel, S. C.; Kramer, K. S.; Chiang, M. Y.; Buhro, W. E. Preparation and x-ray crystal structures of
- volatile copper(II) alkoxides. *Polyhedron* **1990**, *9* (4), 611-613.
- 537 (17) Kunte, G. V.; Shivashankar, S. A.; Umarji, A. M. Thermogravimetric evaluation of the suitability of
- 538 precursors for MOCVD. *Meas. Sci. Technol.* **2008**, *19* (2), 025704.
- 539 (18) Barry, S. T. *Chemistry of Atomic Layer Deposition*; De Gruyter, 2022.
- (19) Koponen, S. E.; Gordon, P. G.; Barry, S. T. Principles of precursor design for vapour deposition
 methods. *Polyhedron* 2016, *108*, 59-66.
- 542 (20) Burger, B. J.; Bercaw, J. E. Vacuum Line Techniques for Handling Air-Sensitive Organometallic
- 543 Compounds. In Experimental Organometallic Chemistry, ACS Symposium Series, Vol. 357; American
- 544 Chemical Society, 1987; pp 79-115.
- 545 (21) Harris, R. K.; Becker, E. D.; Menezes, S. M. C. d.; Goodfellow, R.; Granger, P. NMR nomenclature.
- 546 Nuclear spin properties and conventions for chemical shifts (IUPAC Recommendations 2001). *Pure Appl.*
- 547 *Chem.* **2001**, *73* (11), 1795-1818.
- 548 (22) Sheldrick, G. SHELXT Integrated space-group and crystal-structure determination. *Acta*549 *Crystallographica Section A* 2015, *71* (1), 3-8.
- (23) Sheldrick, G. Crystal structure refinement with SHELXL. *Acta Crystallographica Section C* 2015, *71* (1), 3-8.
- 552 (24) Dolomanov, O. V.; Bourhis, L. J.; Gildea, R. J.; Howard, J. A. K.; Puschmann, H. OLEX2: a
- 553 complete structure solution, refinement and analysis program. J. Appl. Crystallogr. 2009, 42 (2), 339-341.